



# FAST CMOS 1-OF-8 DECODER WITH ENABLE

**IDT54/74FCT138T/AT/CT**

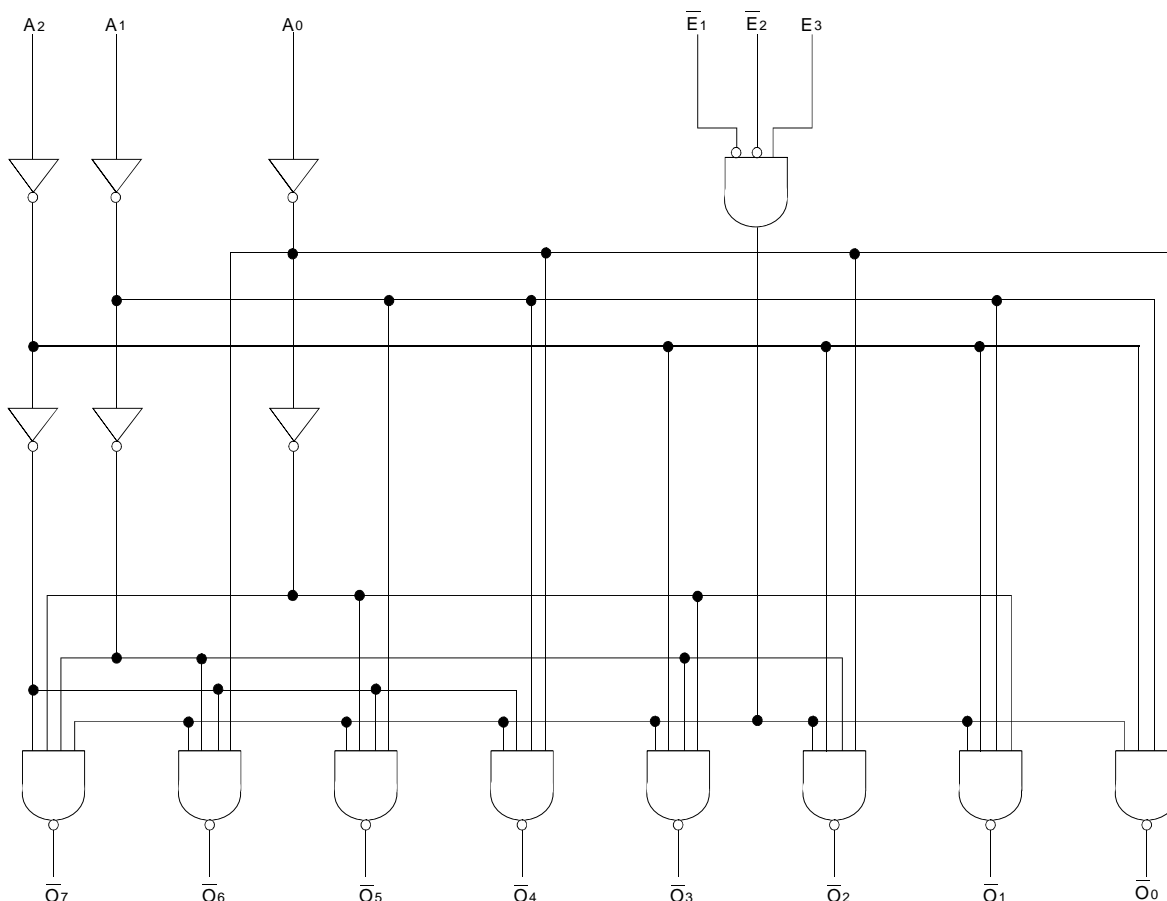
## FEATURES:

- Std., A and C speed grades
- Low input and output leakage  $\leq 1\mu\text{A}$  (max.)
- Extended commercial range of  $-40^\circ\text{C}$  to  $+85^\circ\text{C}$
- CMOS power levels
- True TTL input and output compatibility
  - $V_{OH} = 3.3\text{V}$  (typ.)
  - $V_{OL} = 0.3\text{V}$  (typ.)
- High Drive outputs (-15mA  $I_{OH}$ , 48mA  $I_{OL}$ )
- Meets or exceeds JEDEC standard 18 specifications
- Product available in Radiation Tolerant and Radiation Enhanced versions
- Military product compliant to MIL-STD-883, Class B and DESC listed (dual marked)
- Available in DIP, SOIC, QSOP, CERPACK and LCC packages

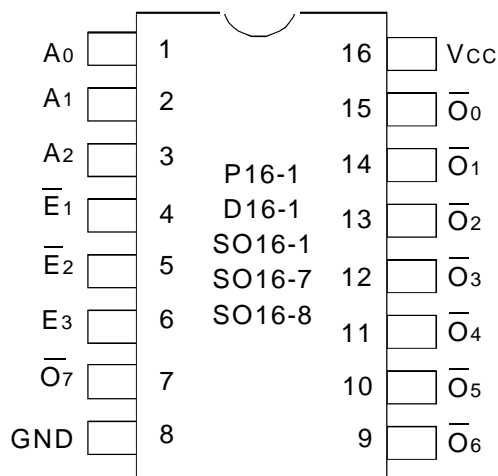
## DESCRIPTION:

The IDT54/74FCT138T/AT/CT are 1-of-8 decoders built using an advanced dual metal CMOS technology. The IDT54/74FCT138T/AT/CT accept three binary weighted inputs ( $A_0$ ,  $A_1$ ,  $A_2$ ) and, when enabled, provide eight mutually exclusive active low outputs ( $\bar{O}_0 - \bar{O}_7$ ). The IDT54/74FCT138T/AT/CT feature three enable inputs, two active low ( $\bar{E}_1$ ,  $\bar{E}_2$ ) and one active high ( $E_3$ ). All outputs will be high unless  $\bar{E}_1$  and  $\bar{E}_2$  are low and  $E_3$  is high. This multiple enable function allows easy parallel expansion of the device to a 1-of-32 (5 lines to 32 lines) decoder with just four IDT54/74FCT138T/AT/CT devices and one inverter.

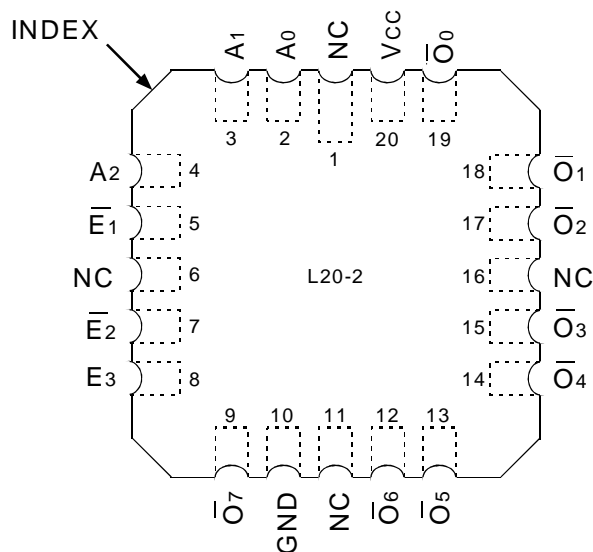
## FUNCTIONAL BLOCK DIAGRAM



## PIN CONFIGURATION



DIP/ SOIC/ QSOP/ CERPACK  
TOP VIEW



LCC  
TOP VIEW

## ABSOLUTE MAXIMUM RATINGS(1)

Symbol	Rating	Max.	Unit
$V_{TERM}^{(2)}$	Terminal Voltage with Respect to GND	-0.5 to +7	V
$V_{TERM}^{(3)}$	Terminal Voltage with Respect to GND	-0.5 to $V_{CC}+0.5$	V
TSTG	Storage Temperature	-65 to +150	°C
I <sub>OUT</sub>	DC Output Current	-60 to +120	mA

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### NOTES:

- Stresses greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability. No terminal voltage may exceed  $V_{CC}$  by +0.5V unless otherwise noted.
- Inputs and  $V_{CC}$  terminals only.
- Outputs and I/O terminals only.

## CAPACITANCE ( $T_A = +25^\circ\text{C}$ , $f = 1.0\text{MHz}$ )

Symbol	Parameter <sup>(1)</sup>	Conditions	Typ.	Max.	Unit
C <sub>IN</sub>	Input Capacitance	$V_{IN} = 0V$	6	10	pF
C <sub>OUT</sub>	Output Capacitance	$V_{OUT} = 0V$	8	12	pF

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### NOTE:

- This parameter is measured at characterization but not tested.

## PIN DESCRIPTION

Pin Names	Description
$A_0 - A_2$	Address Inputs
$\bar{E}_1, \bar{E}_2$	Enable Inputs (Active LOW)
$E_3$	Enable Input (Active HIGH)
$\bar{O}_0 - \bar{O}_7$	Outputs (Active LOW)

## FUNCTION TABLE(1)

Inputs						Outputs							
$\bar{E}_1$	$\bar{E}_2$	$E_3$	$A_0$	$A_1$	$A_2$	$\bar{O}_0$	$\bar{O}_1$	$\bar{O}_2$	$\bar{O}_3$	$\bar{O}_4$	$\bar{O}_5$	$\bar{O}_6$	$\bar{O}_7$
H	X	X	X	X	X	H	H	H	H	H	H	H	H
X	H	X	X	X	X	H	H	H	H	H	H	H	H
X	X	L	X	X	X	H	H	H	H	H	H	H	H
L	L	H	L	L	L	L	H	H	H	H	H	H	H
L	L	H	H	L	L	H	L	H	H	H	H	H	H
L	L	H	L	H	L	H	H	L	H	H	H	H	H
L	L	H	H	H	L	H	H	H	L	H	H	H	H
L	L	H	L	L	H	H	H	H	H	L	H	H	H
L	L	H	H	L	H	H	H	H	H	H	L	H	H
L	L	H	L	H	H	H	H	H	H	H	H	L	H
L	L	H	H	H	H	H	H	H	H	H	H	H	L

**NOTE:**

- H = HIGH Voltage Level  
L = LOW Voltage Level  
X = Don't Care

## DC ELECTRICAL CHARACTERISTICS OVER OPERATING RANGE

Following Conditions Apply Unless Otherwise Specified:

Commercial:  $T_A = -40^\circ\text{C}$  to  $+85^\circ\text{C}$ ,  $V_{CC} = 5.0\text{V} \pm 5\%$ ; Military:  $T_A = -55^\circ\text{C}$  to  $+125^\circ\text{C}$ ,  $V_{CC} = 5.0\text{V} \pm 10\%$

Symbol	Parameter	Test Conditions <sup>(1)</sup>		Min.	Typ. <sup>(2)</sup>	Max.	Unit
$V_{IH}$	Input HIGH Level	Guaranteed Logic HIGH Level		2	—	—	V
$V_{IL}$	Input LOW Level	Guaranteed Logic LOW Level		—	—	0.8	V
$I_{IH}$	Input HIGH Current <sup>(4)</sup>	$V_{CC} = \text{Max.}$	$V_I = 2.7\text{V}$	—	—	$\pm 1$	$\mu\text{A}$
$I_{IL}$	Input LOW Current <sup>(4)</sup>	$V_{CC} = \text{Max.}$	$V_I = 0.5\text{V}$	—	—	$\pm 1$	$\mu\text{A}$
$I_I$	Input HIGH Current <sup>(4)</sup>	$V_{CC} = \text{Max.}, V_I = V_{CC} (\text{Max.})$		—	—	$\pm 1$	$\mu\text{A}$
$V_{IK}$	Clamp Diode Voltage	$V_{CC} = \text{Min.}, I_N = -18\text{mA}$		—	-0.7	-1.2	V
$I_{OS}$	Short Circuit Current	$V_{CC} = \text{Max.}^{(3)}, V_O = \text{GND}$		-60	-120	-225	mA
$V_{OH}$	Output HIGH Voltage	$V_{CC} = \text{Min.}$ $V_{IN} = V_{IH}$ or $V_{IL}$	$I_{OH} = -6\text{mA MIL}$ $I_{OH} = -8\text{mA COM'L}$	2.4	3.3	—	V
			$I_{OH} = -12\text{mA MIL}$ $I_{OH} = -15\text{mA COM'L}$	2	3	—	V
$V_{OL}$	Output LOW Voltage	$V_{CC} = \text{Min.}$ $V_{IN} = V_{IH}$ or $V_{IL}$	$I_{OH} = -32\text{mA MIL}$ $I_{OH} = -48\text{mA COM'L}$	—	0.3	0.5	V
$V_H$	Input Hysteresis	—		—	200	—	mV
$I_{CC}$	Quiescent Power Supply Current	$V_{CC} = \text{Max}$ $V_{IN} = \text{GND}$ or $V_{CC}$		—	0.01	1	mA

**NOTES:**

- For conditions shown as Max. or Min., use appropriate value specified under Electrical Characteristics for the applicable device type.
- Typical values are at  $V_{CC} = 5.0\text{V}$ ,  $+25^\circ\text{C}$  ambient.
- Not more than one output should be shorted at one time. Duration of the short circuit test should not exceed one second.
- The test limit for this parameter is  $\pm 5\mu\text{A}$  at  $T_A = -55^\circ\text{C}$ .

## POWER SUPPLY CHARACTERISTICS

Symbol	Parameter	Test Conditions <sup>(1)</sup>		Min.	Typ. <sup>(2)</sup>	Max.	Unit
$\Delta I_{CC}$	Quiescent Power Supply Current TTL Inputs HIGH	$V_{CC} = \text{Max.}$ $V_{IN} = 3.4V^{(3)}$		—	0.5	2	mA
$I_{CCD}$	Dynamic Power Supply Current <sup>(4)</sup>	$V_{CC} = \text{Max.}$ Outputs Open One Input Toggling 50% Duty Cycle	$V_{IN} = V_{CC}$ $V_{IN} = GND$	—	0.15	0.3	mA/ MHz
$I_C$	Total Power Supply Current <sup>(5)</sup>	$V_{CC} = \text{Max.}$ Outputs Open Toggle $\bar{E}_1, \bar{E}_2,$ or $E_3$ 50% Duty Cycle $f_o = 10\text{MHz}$ One Input and One Output Toggling	$V_{IN} = V_{CC}$ $V_{IN} = GND$	—	1.5	4	mA
			$V_{IN} = 3.4V$ $V_{IN} = GND$	—	1.8	5	

### NOTES:

- For conditions shown as Max. or Min., use appropriate value specified under Electrical Characteristics for the applicable device type.
- Typical values are at  $V_{CC} = 5.0V, +25^\circ\text{C}$  ambient.
- Per TTL driven input ( $V_{IN} = 3.4V$ ); all other inputs at  $V_{CC}$  or  $GND$ .
- This parameter is not directly testable, but is derived for use in Total Power Supply Calculations.
- $I_C = I_{QUIESCENT} + I_{INPUTS} + I_{DYNAMIC}$   
 $I_C = I_{CC} + \Delta I_{CC} \text{DHNT} + I_{CCD} (f_o N_o)$   
 $I_{CC}$  = Quiescent Current  
 $\Delta I_{CC}$  = Power Supply Current for a TTL High Input ( $V_{IN} = 3.4V$ )  
 $DH$  = Duty Cycle for TTL Inputs High  
 $N_T$  = Number of TTL Inputs at  $DH$   
 $I_{CCD}$  = Dynamic Current Caused by an Input Transition Pair (HLH or LHL)  
 $f_o$  = Output Frequency  
 $N_o$  = Number of Outputs at  $f_o$   
 All currents are in milliamps and all frequencies are in megahertz.

## SWITCHING CHARACTERISTICS OVER OPERATING RANGE

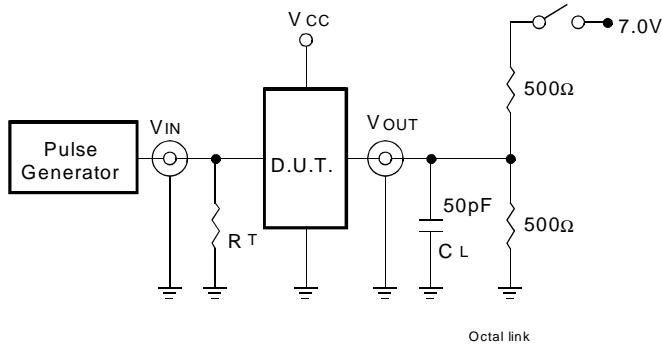
Symbol	Parameter	Condition <sup>(1)</sup>	FCT138T		FCT138AT				FCT138CT				Unit		
			Com'l.		Mil.		Com'l.		Mil.		Com'l.			Mil.	
			Min. <sup>(2)</sup>	Max.	Min. <sup>(2)</sup>	Max.	Min. <sup>(2)</sup>	Max.	Min. <sup>(2)</sup>	Max.	Min. <sup>(2)</sup>	Max.		Min. <sup>(2)</sup>	Max.
$t_{PLH}$ $t_{PHL}$	Propagation Delay $A_N$ to $\bar{O}_N$	$C_L = 50\text{pF}$ $R_L = 500\Omega$	1.5	9	1.5	12	1.5	5.8	1.5	7.8	1.5	5.1	1.5	6	ns
$t_{PLH}$ $t_{PHL}$	Propagation Delay $\bar{E}_1$ or $\bar{E}_2$ to $\bar{O}_N$		1.5	9	1.5	12.5	1.5	5.9	1.5	8	1.5	5.2	1.5	6.1	ns
$t_{PLH}$ $t_{PHL}$	Propagation Delay $E_3$ to $\bar{O}_N$		1.5	9	1.5	12.5	1.5	5.9	1.5	8	1.5	5.2	1.5	6.1	ns

### NOTES:

- See test circuit and wave forms.
- Minimum limits are guaranteed but not tested on Propagation Delays.

## TEST CIRCUITS AND WAVEFORMS

### TEST CIRCUITS FOR ALL OUTPUTS



### SWITCH POSITION

Test	Switch
Open Drain	Closed
Disable Low	
Enable Low	
All Other Tests	Open

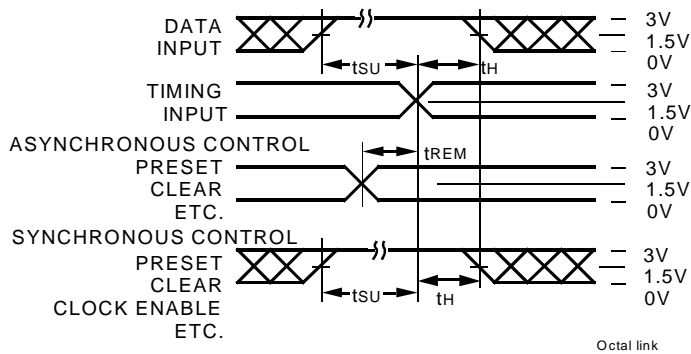
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#### DEFINITIONS:

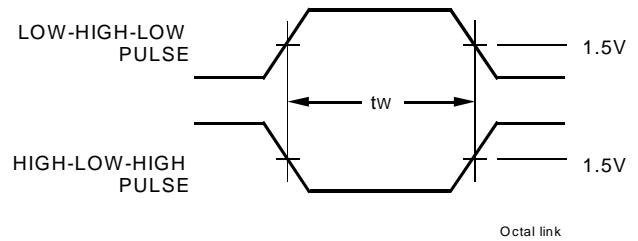
$C_L$  = Load capacitance: includes jig and probe capacitance.

$R_T$  = Termination resistance: should be equal to  $Z_{OUT}$  of the Pulse Generator.

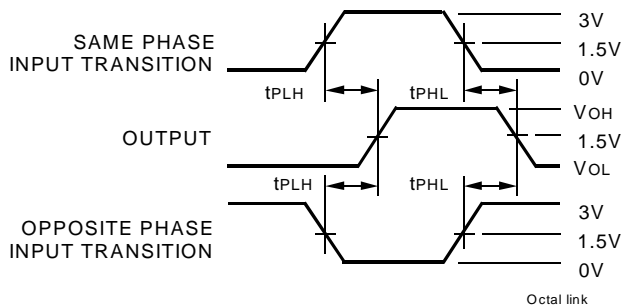
### SET-UP, HOLD, AND RELEASE TIMES



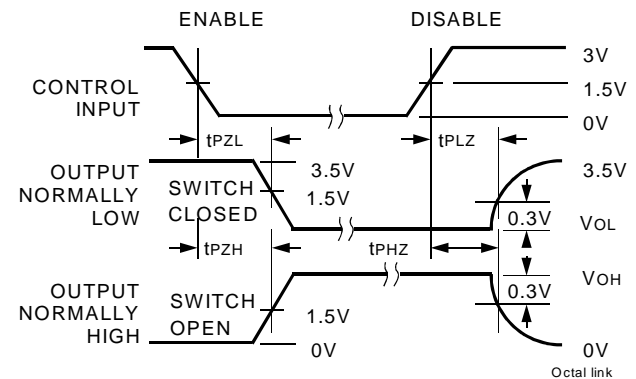
### PULSE WIDTH



### PROPAGATION DELAY



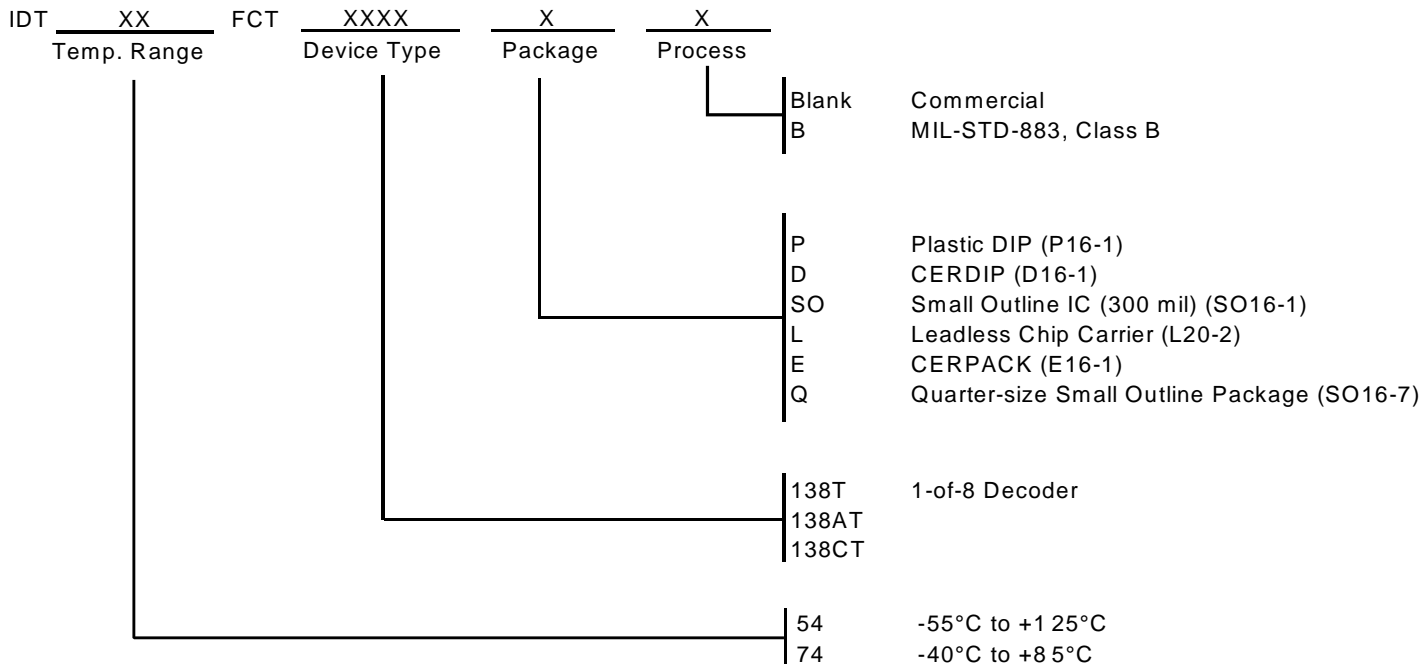
### ENABLE AND DISABLE TIMES



#### NOTES:

- Diagram shown for input Control Enable-LOW and input Control Disable-HIGH.
- Pulse Generator for All Pulses: Rate  $\leq 1.0\text{MHz}$ ;  $t_f \leq 2.5\text{ns}$ ;  $t_r \leq 2.5\text{ns}$ .

**ORDERING INFORMATION**



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